

Description

The AP6G04S uses advanced trench technology

to provide excellent $R_{\text{DS}(\text{ON})},$ low gate charge and

operation with gate voltages as low as 4.5V. This

device is suitable for use as a

Battery protection or in other Switching application.

General Features

V_{DS} = 40V I_D =6A

 $R_{DS(ON)}$ < 26m Ω @ V_{GS} =10V

 $V_{DS} = -40V I_{D} = 6A$

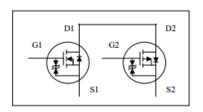
 $R_{DS(ON)} < 32m\Omega$ @ $V_{GS}=10V$

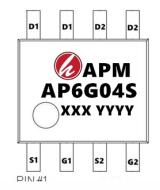
Application

Battery protection

Load switch

Uninterruptible power supply







Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)			
AP6G04S	SOP-8	AP6G04S XXX YYYY	3000			

Absolute Maximum Ratings (Tc=25℃ unless otherwise noted)

		Rating		
Symbol Parameter		N-Ch	N-Ch P-Ch	
Vps	Drain-Source Voltage	40	-40	V
Vgs	Gate-Source Voltage	±20	±20	V
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	6.1	-6	Α
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	4.9	-4.8	Α
Ірм	Pulsed Drain Current ²	23	-22	Α
EAS	Single Pulse Avalanche Energy ³	16.2	39	mJ
las	Avalanche Current	18	-28	Α
P _D @T _A =25°C	Total Power Dissipation ⁴	1.67	1.67	W
Тѕтс	Storage Temperature Range	-55 to 150	-55 to 150	°C
TJ	Operating Junction Temperature Range -55 to 150 -55 to 150		°C	
Reja	Thermal Resistance Junction-Ambient ¹	75		°C/W
Rejc	Thermal Resistance Junction-Case ¹	30		°C/W



N-Channel Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	40			V	
2BVpss/2Tj	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.034		V/°C	
		V _{GS} =10V , I _D =5A			26		
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =4A			35	$m\Omega$	
V _{GS} (th)	Gate Threshold Voltage		1.0		2.5	V	
₹VGS(th)	V _{GS(th)} Temperature Coefficient	V _{GS} =V _{DS} , I _D =250uA		-4.56		mV/°C	
		V _{DS} =32V , V _{GS} =0V , T _J =25°C			1	uA	
loss	Drain-Source Leakage Current	V _{DS} =32V , V _{GS} =0V , T _J =55 °C			5		
Igss	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA	
gfs	Forward Transconductance	V _{DS} =5V , I _D =5A		14		S	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		2.6			
Qg	Total Gate Charge (4.5V)			5.5			
Qgs	Gate-Source Charge	V _{DS} =20V , V _{GS} =4.5V , I _D =5A		1.25		nC	
Q _{gd}	Gate-Drain Charge			2.5			
Td(on)	Turn-On Delay Time			8.9			
Tr	Rise Time	V _{DD} =20V , V _{GS} =10V ,		2.2			
Td(off)	Turn-Off Delay Time	R _G =3.3 I _D =1A		41		ns	
Tf	Fall Time			2.7			
Ciss	Input Capacitance			593			
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		76		pF	
Crss	Reverse Transfer Capacitance			56			
ls	Continuous Source Current ^{1,5}				6.1	Α	
lsм	Pulsed Source Current ^{2,5}	V _G =V _D =0V , Force Current			23	Α	
VsD	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25 °C			1.2	V	

Note:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leqq 300 us$, duty cycle $\leqq 2\%$
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH, I_{AS} =18A
- 4. The power dissipation is limited by 150° C junction temperature 5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



P-Channel Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	Vcs=0V , In=-250uA	-40			V	
2BVpss/2Tj	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.02		V/°C	
		V _{GS} =-10V , I _D =-6A			32		
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =-4.5V , I _D =-3A			46	$\mathbf{m}\Omega$	
V _{GS} (th)	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =-250uA	-1.0		-2.5	V	
$?V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	,		3.72		mV/°C	
		V _{DS} =-32V , V _{GS} =0V , T _J =25°C			1		
loss	Drain-Source Leakage Current	V _{DS} =-32V , V _{GS} =0V , T _J =55°C			5	uA	
Igss	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$			±100	nA	
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-6A		13		S	
Qg	Total Gate Charge (-4.5V)			11.5			
Q_{gs}	Gate-Source Charge	V _{DS} =-20V , V _{GS} =-4.5V , I _D =-6A		3.5		nC	
Q_{gd}	Gate-Drain Charge			3.3			
Td(on)	Turn-On Delay Time			22			
Tr	Rise Time	V _{DD} =-15V , V _{GS} =-10V , R _G =3.3 ,		15.7			
$T_{d(off)}$	Turn-Off Delay Time	I _D =-1A		59		ns	
T _f	Fall Time			5.5			
C _{iss}	Input Capacitance			1415			
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		134		pF	
Crss	Reverse Transfer Capacitance			102			
ls	Continuous Source Current ^{1,5}	V _G =V _D =0V , Force Current			-6	Α	
lsм	Pulsed Source Current ^{2,5}				-22	Α	
VsD	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1.2	V	

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\,\leq\,300\text{us}$, duty cycle $\,\leq\,2\%$
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =-25V, V_{GS} =-10V, L=0.1mH, I_{AS} =-28A
- 4. The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



N-Channel Typical Characteristics

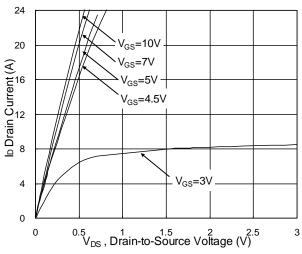


Fig.1 Typical Output Characteristics

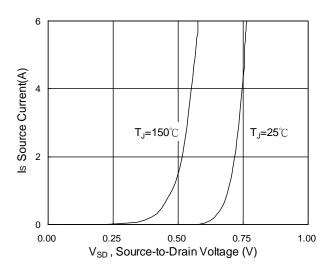


Fig.3 Forward Characteristics of Reverse

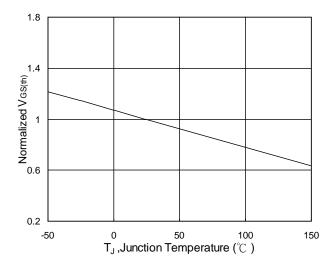


Fig.5 Normalized $V_{\text{GS(th)}}$ vs. T_J

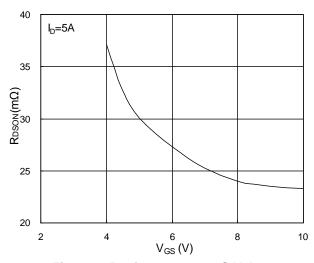


Fig.2 On-Resistance vs. G-S Voltage

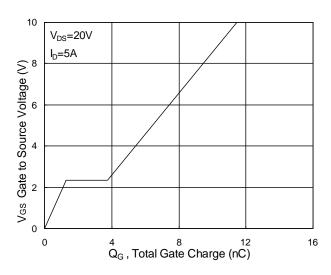


Fig.4 Gate-Charge Characteristics

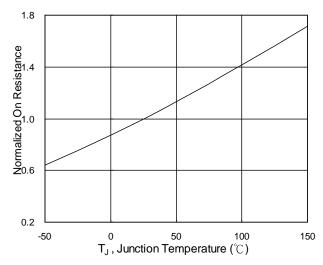
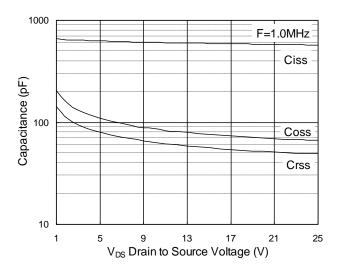


Fig.6 Normalized R_{DSON} vs. T_J





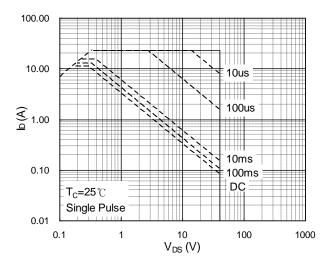


Fig.7 Capacitance

Fig.8 Safe Operating Area

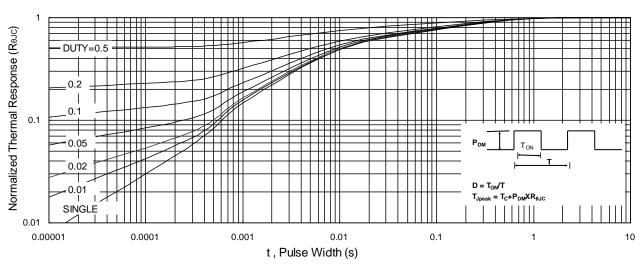


Fig.9 Normalized Maximum Transient Thermal Impedance

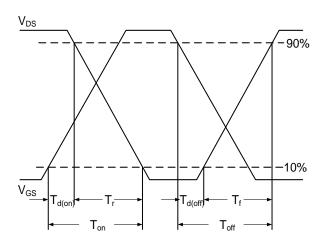


Fig.10 Switching Time Waveform

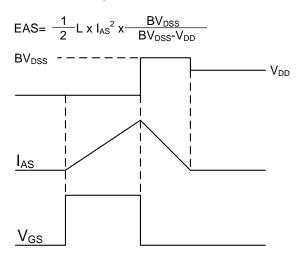


Fig.11 Unclamped Inductive Switching Wave





P-Channel Typical Characteristics

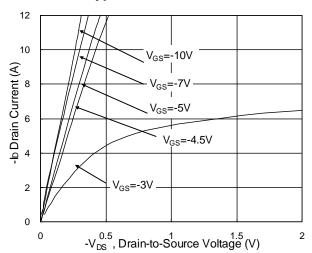


Fig.1 Typical Output Characteristics

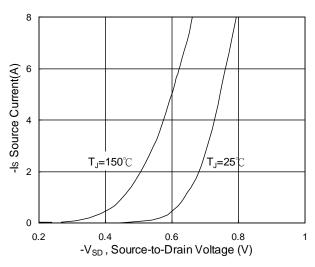


Fig.3 Forward Characteristics of Reverse

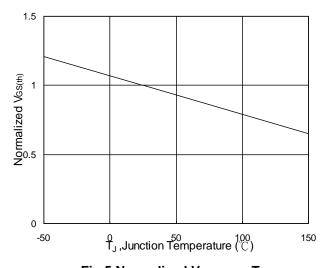


Fig.5 Normalized $V_{\text{GS(th)}}$ v.s T_{J}

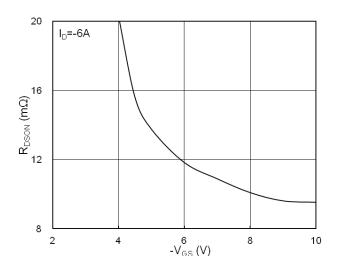


Fig.2 On-Resistance v.s Gate-Source

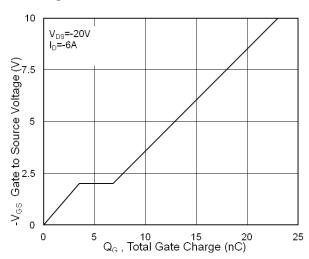


Fig.4 Gate-Charge Characteristics

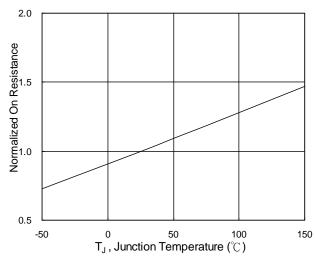
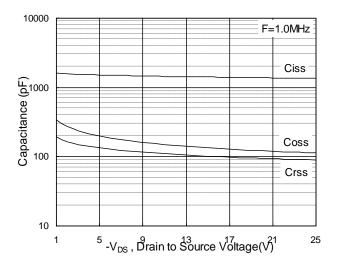


Fig.6 Normalized R_{DSON} v.s T_J







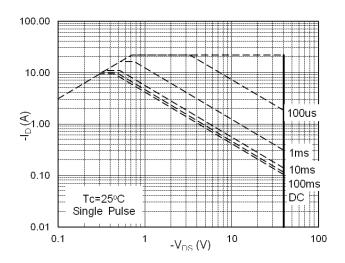


Fig.7 Capacitance

Fig.8 Safe Operating Area

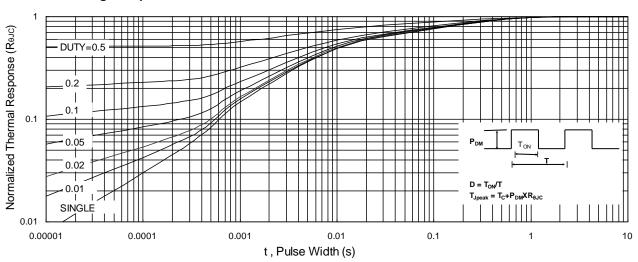


Fig.9 Normalized Maximum Transient Thermal Impedance

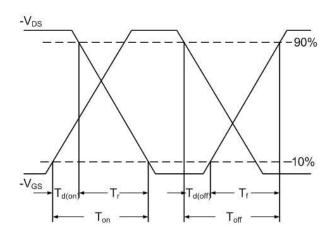


Fig.10 Switching Time Waveform

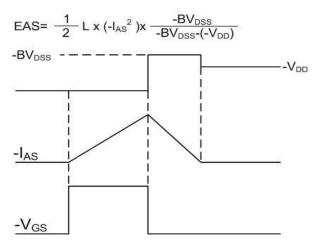
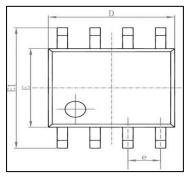


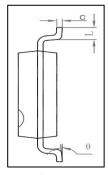
Fig.11 Unclamped Inductive Waveform

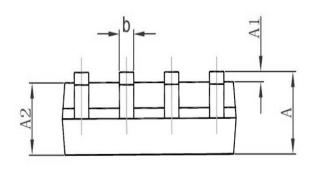




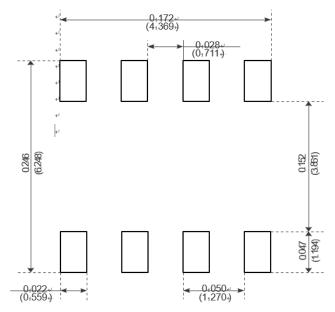
Package Mechanical Data-SOP-8







Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min	Max	Min	Max	
Α	1. 350	1. 750	0. 053	0.069	
A1	0. 100	0. 250	0. 004	0. 010	
A2	1. 350	1. 550	0. 053	0. 061	
b	0. 330	0. 510	0. 013	0. 020	
С	0. 170	0. 250	0. 006	0. 010	
D	4. 700	5. 100	0. 185	0. 200	
E	3. 800	4. 000	0. 150	0. 157	
E1	5. 800	6. 200	0. 228	0. 244	
е	1. 270 (BSC)		0. 050 (BSC)		
L	0. 400	1. 270	0. 016	0.050	
θ	0°	8°	0°	8°	



Recommended Minimum Pads-





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